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Bib Data Sheet

CONFIRMATION NO. 1763

SERIAL NUMBER 10/750,443	FILING DATE 12/30/2003 RULE	CLASS 438	GROUP ART UNIT 2818	ATTORNEY DOCKET NO. 4717-8300
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APPLICANTS

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** CONTINUING DATA *****

This application is a CON of PCT/FR02/02341 07/04/2002

** FOREIGN APPLICATIONS *****

FRANCE 0108859 07/04/2001

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 05/03/2004

Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	STATE OR	SHEETS	TOTAL	INDEPENDENT
35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	COUNTRY	DRAWING	CLAIMS	CLAIMS
Verified and Acknowledged Examiner's Signature: <i>[Signature]</i> Initials: <i>PD</i>	FRANCE	1	20	2

ADDRESS

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TITLE

Method for reducing free surface roughness of a semiconductor wafer

FILING FEE	RECEIVED	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees
			<input type="checkbox"/> 1.16 Fees (Filing)
			<input type="checkbox"/> 1.17 Fees (Processing Ext. of time)